

<b>Notice of References Cited</b>	Application/Control No. 10/531,042	Applicant(s)/Patent Under Reexamination KENNEDY ET AL.	
	Examiner <i>K.P.</i> Kamran Afshar, 571-272-7796	Art Unit 2617	Page 1 of 1

#### U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2004/0266457 A1	12-2004	Dupray, Dennis J.	455/456.5
*	B	US-2004/0220728 A1	11-2004	Cayford, Randall	701/209
*	C	US-2002/0175855 A1	11-2002	Richton et al.	342/357.02
*	D	US-2002/0111158 A1	08-2002	Tee, Lai King	455/436
*	E	US-2003/0054813 A1	03-2003	Riley et al.	455/446
*	F	US-2002/0151325 A1	10-2002	Fitton et al.	455/553
*	G	US-2004/0067759 A1	04-2004	Spirito et al.	455/456.1
*	H	US-2004/0198279 A1	10-2004	Anttila et al.	455/456.1
*	I	US-2005/0164712 A1	07-2005	Kennedy et al.	455/456.1
*	J	US-2005/0136945 A1	06-2005	Kennedy et al.	455/456.1
*	K	US-6,952,158 B2	10-2005	Kennedy, Jr., Joseph P.	455/456.1
*	L	US-6,920,329 B2	07-2005	Kennedy et al.	455/456.1
	M	US-			

#### FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

#### NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.